

Notice of References Cited

Application/Control No.

10/763,353

Applicant(s)/Patent Under
Reexamination
HOFFMAN ET AL.

Examiner

JOHANNES P. MONDT

Art Unit

3663

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U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Young et al., "Growth and characterization of radio frequency magnetron sputter-deposited zinc stannate, Zn ₂ SnO ₄ , thin films", Journal of Applied Physics, Volume 92, Number 1 (July 1, 2002), pages 310-319, especially section V.			
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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